





#### **40V HIGH CURRENT LOW LEAKAGE SCHOTTKY DIODE**

#### **Features**

- Low Equivalent on Resistance
- Extremely Low Leakage (typically 6μA @30V)
- High current capability (I<sub>F</sub> = 1.16A)
- Low V<sub>F</sub>, Fast Switching Schottky
- SOT-23 Package
- ZLLS1000 Complements Low Temperature Equivalent ZHCS1000
- Package Thermally Rated to 150°C
- Lead, Halogen, and Antimony Free/RoHS Compliant (Note 1)
- "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

### **Mechanical Data**

- Case: SOT-23
- UL Flammability Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Matte Tin Finish
- Weight: 0.008 grams (Approximate)

### **Applications**

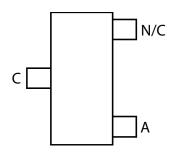
- DC DC converters
- Strobes
- Mobile phones
- · Charging circuits
- Motor control



SOT-23



**Device symbol** 



Pinout - top view

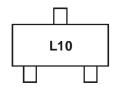
## **Ordering Information**

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
ZLLS1000TA	L10	7	8	3,000 units
ZLLS1000TC	L10	13	8	10.000 units

Notes:

- 1. No purposefully added lead. Halogen and Antimony Free.
- 2. Diodes Inc's "Green" Policy can be found on our website at http://www.diodes.com

## **Marking Information**



L10 = Product type Marking Code



### **Maximum Ratings** @T<sub>A</sub> = 25°C unless otherwise specified

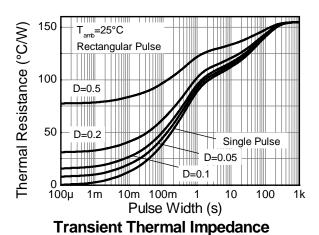
Characteristic		Symbol	Value	Unit
Continuous Reverse Voltage		V <sub>R</sub>	40	V
Forward Current		I <sub>F</sub>	1.16	Α
Peak Repetitive Forward Current Rectangular Pulse Duty Cycle 50% 100µs pulse width		I <sub>FPK</sub>	2.6	А
Non Repetitive Forward Current	t≤100µs t≤10ms	I <sub>FSM</sub>	22 6.4	A A

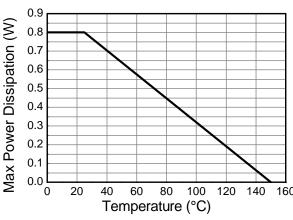
### **Thermal Characteristics**

Chara	Symbol	Value	Unit	
Power Dissipation @T <sub>A</sub> = 25°C	Single Die Continuous Single Die Measured at t<5 secs	$P_{D}$	0.8 1.18	W
Thermal Resistance Junction to Ambient (Note 3)		$R_{\theta JA}$	155	°C/W
Thermal Resistance Junction to Ambient (Note 4)		$R_{\theta JA}$	106	°C/W
Thermal Resistance Junction to Lead (Solder Point)		$R_{\theta JL}$	80	°C/W
Storage temperature range		T <sub>STG</sub>	-55 to +150	°C
Junction temperature		TJ	150	°C

es: 3. For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions. 4. For a device mounted on FRB PCB measured at t<5secs.

# **Thermal Characteristics and Derating information**







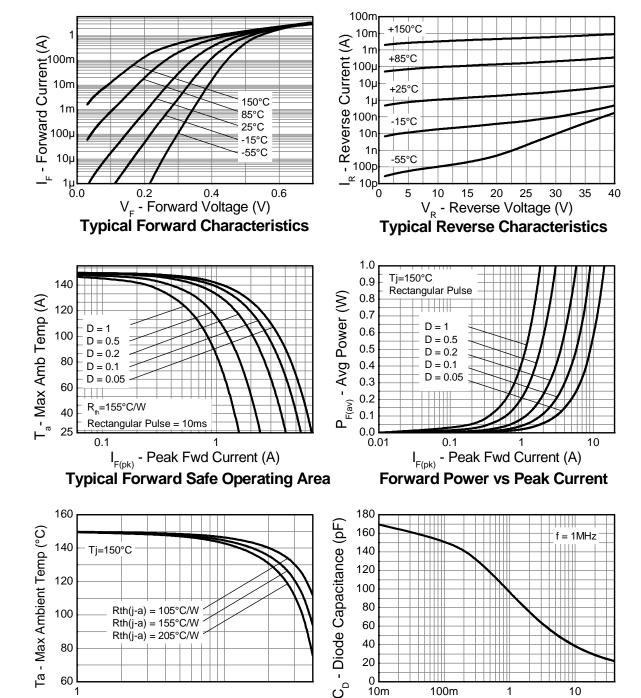


# Electrical Characteristics @T<sub>A</sub> = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
Reverse breakdown voltage	$V_{(BR)R}$	40	-	-	V	$I_R = 500 \mu A$
	V <sub>F</sub>	-	320	355	mV	$I_F = 50 \text{mA}$
			335	380		$I_F = 100 \text{mA}$
			380	425		$I_F = 250 \text{mA}$
Forward valtage (Note F)			410	460		$I_F = 500 \text{mA}$
Forward voltage (Note 5)			440	510		$I_F = 750 \text{mA}$
			470	560		$I_F = 1A$
			530	660		$I_F = 1.5A$
			430	-		I <sub>F</sub> = 1000mA, T <sub>A</sub> = 100°C
Reverse current	I <sub>R</sub>	-	5	20	μA	V <sub>R</sub> = 30V
Reverse current			500	-	μA	$V_R = 30V, T_A = 85^{\circ}C$
Diode capacitance	C <sub>D</sub>	-	28	-	pF	$f = 1MHz$ , $V_R = 30V$
Reverse recovery time Reverse recovery charge	t <sub>rr</sub> Q <sub>rr</sub>	-	5 350	-	ns nC	Switched from I <sub>F</sub> = 500mA to V <sub>R</sub> = 5.5V Measured @ I <sub>R</sub> 50mA. di /dt = 500mA/ ns. $R_{source} = 6\Omega$ ; $R_{load} = 10\Omega$

Notes: 5. Measured under pulsed conditions. Pulse width =  $300\mu$ s. Duty cycle < 2%





80

 $Rth(\ddot{j}-a) = 155$ °C/W

Rth(j-a) = 205°C/W

V<sub>P</sub> - Continuous Reverse Voltage (V)

Typical Reverse Safe Operating Area

60

40

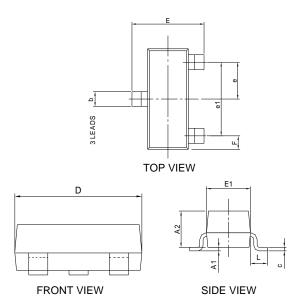
20 0 10m

V<sub>R</sub> - Reverse Voltage (V)

Capacitance vs Reverse Voltage

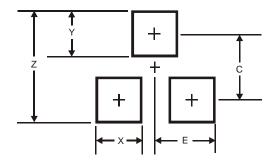


# **Package Outline Dimensions**



SOT-23					
Dim	Min Max		Тур		
<b>A</b> 1	0.013	0.100	0.05		
A2	0.903	1.100	1.00		
b	0.37	0.51	0.40		
С	0.85	0.180	0.110		
D	2.80	3.00	2.90		
E	2.30	2.50	2.40		
E1	1.20	1.40	1.30		
е	0.89	1.03	0.915		
e1	1.78	2.05	1.83		
F	0.45	0.60	0.535		
L	0.45	0.60	0.535		
All Dimensions in mm					

# **Suggested Pad Layout**



Dimensions	Value (in mm)		
Z	2.9		
Х	0.8		
Y	0.9		
С	2.0		
Ш	1.35		





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